


<b>Search Notes</b>  	<b>Application/Control No.</b>  10759325	<b>Applicant(s)/Patent Under Reexamination</b>  PAFF ET AL.
	<b>Examiner</b>  Chun-Kuan Lee	<b>Art Unit</b>  2181

SEARCHED			
Class	Subclass	Date	Examiner
710	62	4/16/2008	CKL

SEARCH NOTES		
Search Notes	Date	Examiner
Updated EAST search:US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	4/16/2008	CKL
Updated inventor search utilizing eDan and EAST	4/16/2008	CKL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner